

Issue Date : August 15, 2006
Page 1 of 37

***EMC* EMISSION - TEST REPORT**

JQA APPLICATION No. : KL80060199

Name of Product : WCDMA & Tri-band GSM Dual mode Mobile Phone / Bluetooth
Enable

Model/Type No. : 810SH

FCC ID : APYHRO00050

Applicant : Sharp Corporation, Communication Systems Group

Address : 2-13-1, Iida Hachihonmatsu, Higashihiroshima-city,
Hiroshima 739-0192, JAPAN

Manufacturer : Sharp Corporation, Communication Systems Group

Address : 2-13-1, Iida Hachihonmatsu, Higashihiroshima-city,
Hiroshima 739-0192, JAPAN

Receive date of EUT : July 31, 2006

Test Results : **passed**

TEST RESULTS IN THIS REPORT are obtained in use of equipment that is traceable to National Institute of Advanced Industrial Science and Technology (AIST) under METI Japan and National Institute of Information and Communications Technology(NICT) under MPHPT Japan.

THE TEST RESULTS only responds to the test sample. This test report shall not be reproduced except in full.

Authorized by:



Yuichi Fukumoto, Manager
JQA KITA-KANSAI Testing Center

DIRECTORY

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TEST REGULATION

FCC Rules and Regulations Part 24 (October 1, 2004)

1900 MHz systems (Part 24)

- - Narrowband PCS
- - Broadband PCS

Test procedure:

The tests were performed according to FCC Rules and Regulations Part 2 (October 1, 2003), and ANSI C63.4 (2003).

GENERAL INFORMATION

Test facility:

- 1) Test Facility located at Kita-Kansai : 1st Open Site (3 m Site)
Test Facility located at Kameoka : 1st Open Site (3, 10 and 30 m, on common plane)
: 2nd Open Site (3 and 10 m, on common plane)

FCC filing No. : 31040/SIT 1300F2

- 2) KITA-KANSAI TESTING CENTER is recognized under the National Voluntary Laboratory Accreditation Program for satisfactory compliance established in Title 15, Part 285 Code of Federal Regulations.
NVLAP Lab Code: 200191-0

Definitions for symbols used in this test report:

- - Black box indicates that the listed condition, standard or equipment is applicable for this Report.
- - Blank box indicates that the listed condition, standard or equipment is not applicable for this Report.

Description of the Equipment Under Test (EUT):

- 1) Name : WCDMA & Tri-band GSM Dual mode Mobile Phone / Bluetooth Enable
2) Model/Type No. : 810SH
3) Product Type : Pre-production(Serial No.: 004401/11/020464/7)
4) Category : Broadband PCS
5) EUT Authorization : ○ - Verification ● - Certification ○ - D.o.C.
6) Transmitting Frequency : 1850.2 MHz (512 ch) - 1909.8 MHz (810 ch)(PCS1900)
7) Receiving Frequency : 1930.2 MHz (512 ch) - 1989.8 MHz (810 ch) (PCS1900)
8) Integrated Antenna : L Type antenna
9) Emission Designations : 246KGXW(PCS1900)
10) Maximum RF Output Power : 1.585W(EIRP)(PCS1900)
11) Power Rating : 4.0VDC
12) Channel Numbers and Frequencies :

PCS1900

The carrier spacing is 200 kHz.

The carrier frequency is designated by the absolute frequency channel number (ARFCN).

The carrier frequency is expressed in the equation shown as follows:

$$\text{TX frequency (in MHz)} = 1850.2 + 0.2 \times (n - 512)$$

$$\text{RX frequency (in MHz)} = 1930.2 + 0.2 \times (n - 512)$$

Where n : Channel Number ($512 \leq n \leq 810$)

- 13) Modulation Type : GMSK
14) Type of Communication System : GSM

TEST CONDITIONS

Transmitter Power (TP) Measurement (§2.1046(a))

Test Procedure :

The Transmitter Power was measured with a power meter, two 10 dB attenuators and a short, low loss cable.

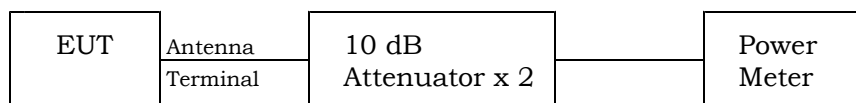


Fig.1 Transmitter Power Measurement

Test location :

KITA-KANSAI Testing Center

7-7, Ishimaru, 1-Chome, Mino-Shi, Osaka, 562-0027, Japan

○ - Shielded room

KAMEOKA EMC Branch

9-1, Ozaki, Inukanno, Nishibetsuin-Cho, Kameoka-Shi, Kyoto, 621-0126, Japan

● - Shielded room

Used test instruments and sites :

Model No.	Device ID	Last Cal. Date	Cal. Interval
○ - E4417A	B - 51		
○ - E9321A	B - 52		
● - N1911A	B - 63	June, 2006	1 Year
● - N1921A	B - 64	June, 2006	1 Year
○ - 6-20	D - 27		
○ - 4T-10	D - 73		
○ - 4T-10	D - 74		
○ - 2-10	D - 79		
○ - 2-10	D - 80		
● - 54-10	D - 82	May, 2006	1 Year
● - 54-10	D - 83	May, 2006	1 Year

Environmental conditions :

Temperature: 26 °C Humidity: 61 %

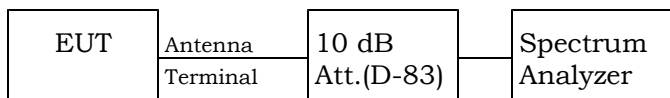
Antenna Conducted Spurious Emission Measurement (§2.1051,§24.238)

Test Procedure :

The Antenna Conducted Emission was measured with a spectrum analyzer. The test system is shown as follows:

PCS1900

1) Frequency Range : 9kHz - 2GHz



2) Frequency Range : 2GHz - 20GHz

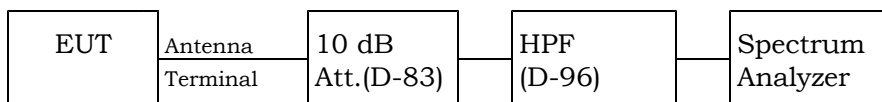


Fig.2 Antenna Conducted Spurious Emission Measurement

The setting of the spectrum analyzer are shown as follows :

Frequency Range	9kHz - 150kHz	150kHz - 30 MHz	30 MHz - 20 GHz
Res. Bandwidth	200 Hz	10 kHz	1 MHz
Video Bandwidth	1 kHz	30 kHz	3 MHz
Sweep Time	AUTO	AUTO	AUTO
Trace	Maxhold	Maxhold	Maxhold

Test location :

KITA-KANSAI Testing Center

7-7, Ishimaru, 1-Chome, Mino-Shi, Osaka, 562-0027, Japan

● - Shielded room

KAMEOKA EMC Branch

9-1, Ozaki, Inukanno, Nishibetsuin-Cho, Kameoka-Shi, Kyoto, 621-0126, Japan

○ - Shielded room

Used test instruments:

Model No.	Device ID	Last Cal. Date	Cal. Interval
○ - 8566B	A - 13	November, 2005	1 Year
● - E4446A	A - 39		
○ - 4T-10	D - 73		
○ - 4T-10	D - 74		
○ - 2-10	D - 79		
○ - 2-10	D - 80	May, 2006	1 Year
○ - 54-10	D - 82		
● - 54-10	D - 83		
○ - BRM50701	D - 93		
○ - HPM13900	D - 95		
● - HPM13899	D - 96	February, 2006	1 Year

Environmental conditions:

Temperature: 26 °C Humidity: 61 %

Transmitter Power (EIRP) Measurement (§24.232)**Test Procedure :**

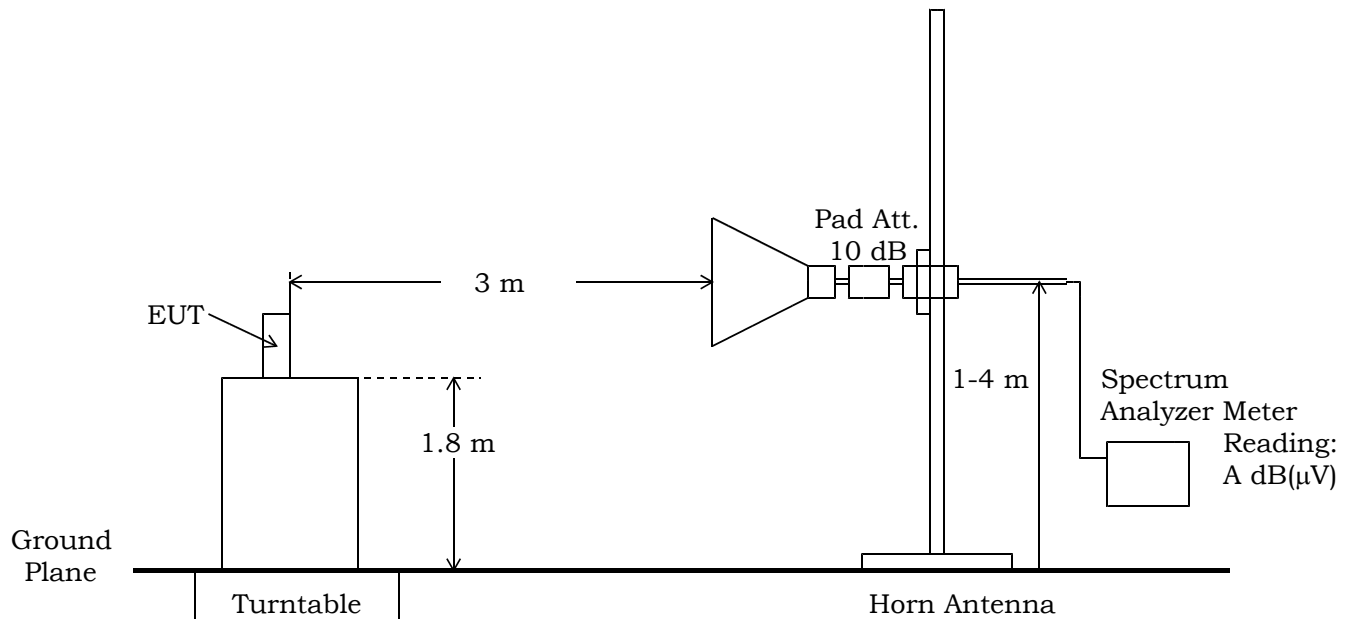
Step 1) The test was set-up shown as Fig.3 (a). In order to obtain the maximum emission, the EUT is placed at the height 1.8m on the non-conducted support and was varying at three orthogonal axes(Refer to pages 27 - 28), at the distance 3m from the receiving antenna (Horn Antenna) and rotated around 360 degrees. The receiving antenna height was varied from 1 m to 4 m. The EUT on the table was placed to be maximum emission against the receiving antenna polarized (Vertical and Horizontal). Then the meter reading of the spectrum analyzer at the maximum emission was A dB(μV).

Step 2) The test was set-up shown as Fig.3 (b). The EUT was replaced to Horn antenna at the same polarized under the same condition as step 1. The RF power was fed to the transmitting Antenna (Horn Antenna) through the RF amplifier from the signal generator. In order to obtain the maximum emission level, the height of the receiving antenna is varied from 1 m to 4 m. The level of the signal generator was adjusted so that the meter reading of the spectrum analyzer at the maximum emission was A dB(μV), same as the recorded level in step 1. Then the RF power into the substitution horn antenna was P(dBm).

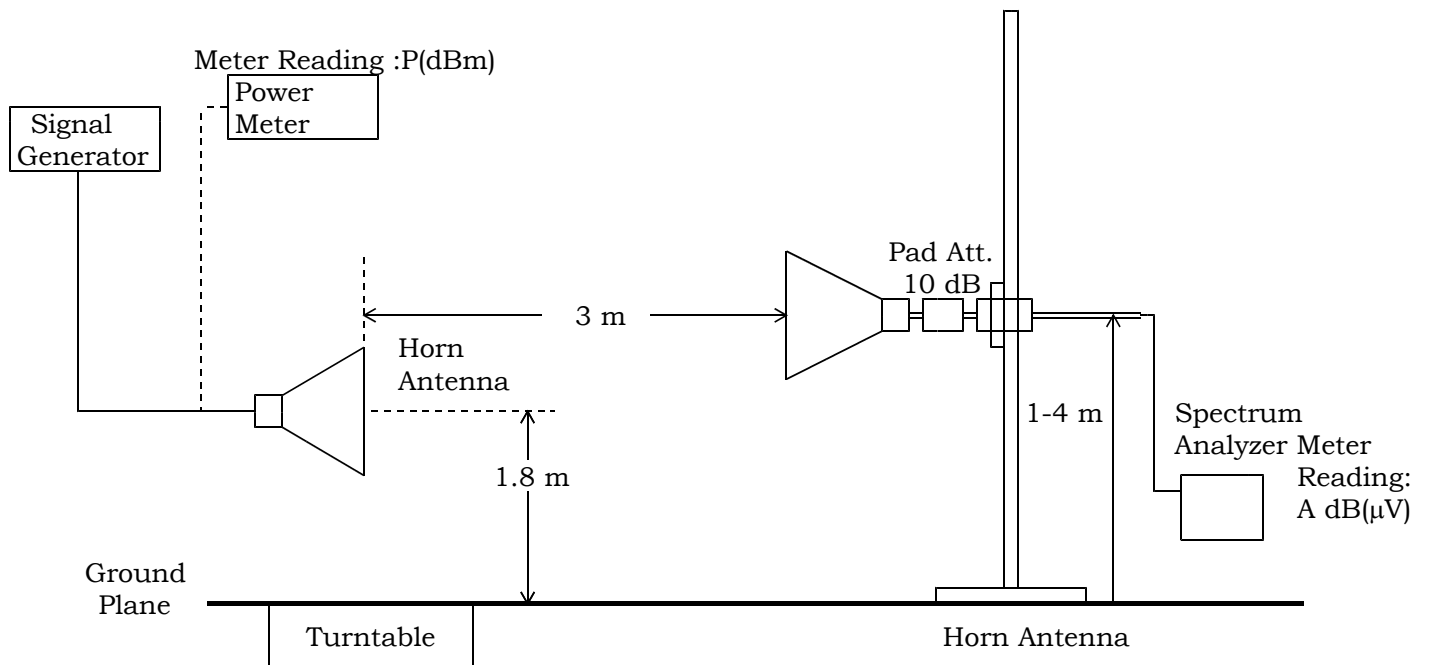
The EIRP is calculated in the following equation.

$$\text{EIRP (dBm)} = P \text{ (dBm)} + G_h \text{ (dBi)}$$

Where, $G_h \text{ (dBi)}$: Gain of the substitution horn antenna



(a) EUT



(b) Substitution Horn Antenna

Fig.3 Maximum Transmitter Power (EIRP) Measurement

Test location:

KITA-KANSAI Testing Center

7-7, Ishimaru, 1-Chome, Mino-Shi, Osaka, 562-0027, Japan

● - 1st open test site (3 meters)

KAMEOKA EMC Branch

9-1, Ozaki, Inukanno, Nishibetsuin-Cho, Kameoka-Shi, Kyoto, 621-0126, Japan

○ - 1st open test site ○ - 3 m ○ - 10 m ○ - 30 m

○ - 2nd open test site ○ - 3 m ○ - 10 m

Used test instruments:

Model No.	Device ID	Last Cal. Date	Cal. Interval
○ - ESCS 30	A - 1		
○ - ESCS 30	A - 9		
○ - 8566B	A - 13		
● - E4446A	A - 39	November, 2005	1 Year
○ - ESV	A - 6		
● - 4T-10	D - 73	May, 2006	1 Year
○ - 4T-10	D - 74		
○ - 2-10	D - 79		
○ - 2-10	D - 80		
● - 91888-2	C - 40 - 1	June, 2006	1 Year
● - 91888-2	C - 41 - 1	June, 2006	1 Year
○ - 91889-2	C - 40 - 2		
○ - 91889-2	C - 41 - 2		
● - Cable	C - 40 - 11	May, 2006	1 Year
● - Cable	C - 40 - 12	May, 2006	1 Year
○ - E4417A	B - 51		
○ - E9321A	B - 52		
● - N1911A	B - 63	June, 2006	1 Year
● - N1921A	B - 64	June, 2006	1 Year
● - E8257D	B - 39	July, 2005	2 Years
○ - 6062A	B - 44		

Temperature: 24 °C Humidity: 68 %

Unwanted Radiation Measurement (§2.1053,§22.917,§24.238) - ERP method -

Test Procedure :

Step 1) The spurious radiation for transmitter were measured at the distance 3 m away from the EUT which was placed on a non-conducted support 1.0 m in height and was varying at three orthogonal axes(Refer to pages 27 - 28). The receiving antenna was oriented for vertical polarization and varied from 1 m to 4 m until the maximum emission level was detected on the measuring instrument. The EUT was rotated 360 degrees until the maximum emission was received. The measurement was also repeated with the receiving antenna in the horizontal polarization. This test was carried out using the loop antenna for up to 30 MHz, using the half-wave dipole antenna for up to 1GHz and using the horn antenna for above 1 GHz.

Step 2) The ERP measurement was carried out with according to Step 2 in page 9. Then the RF power in the substitution antenna half-wave dipole antenna for up to 1 GHz and the substitution horn antenna for above 1 GHz.

The EIRP is calculated in the following equation.

A) Up to 1 GHz

$$\text{ERP(dBm)} = P \text{ (dBm)} - (\text{Balun Loss of the half-wave dipole Ant. (dB)}) + \text{Cable Loss(dB)}$$

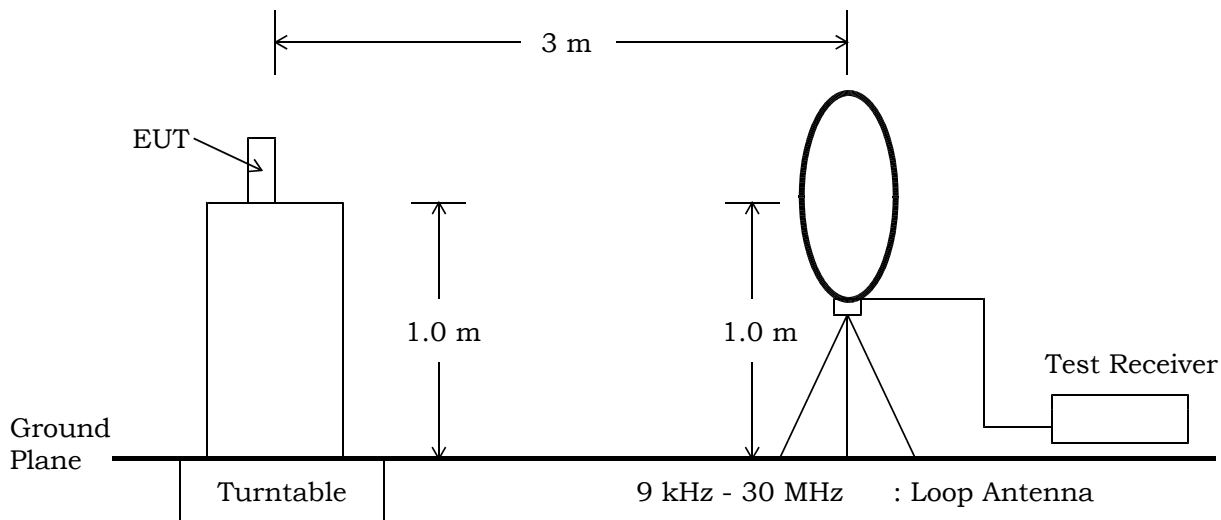
B) Above 1 GHz

$$\text{ERP(dBm)} = P \text{ (dBm)} + G_h(\text{dBi}) - G_d(\text{dBi})$$

Where, $G_h(\text{dBi})$: Gain of the substitution horn antenna

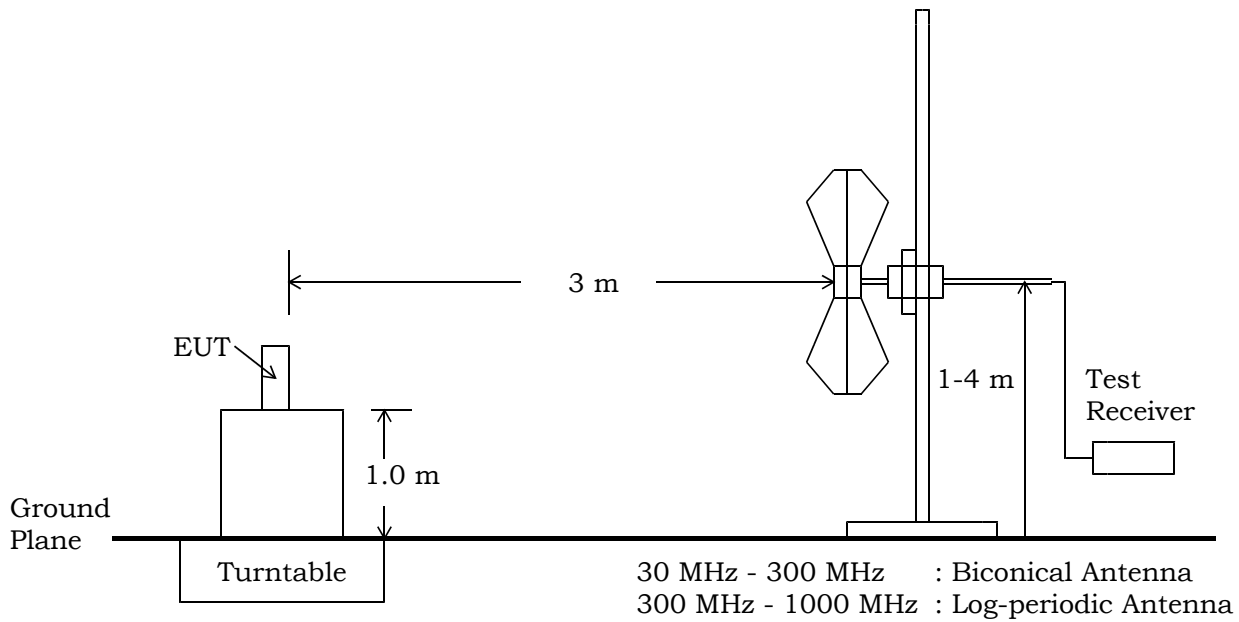
$G_d(\text{dBi})$: Gain of the substitution half-wave dipole antenna

The respective calculated ERP of the spurious and harmonics were compared with the EIRP and ERP of fundamental frequency by specified attenuation limits, $43 + 10 \log_{10} (\text{TP in watt}) [\text{dB}]$. Where, TP = Transmitter power at the ANT OUT under test configuration as the hands free unit used.

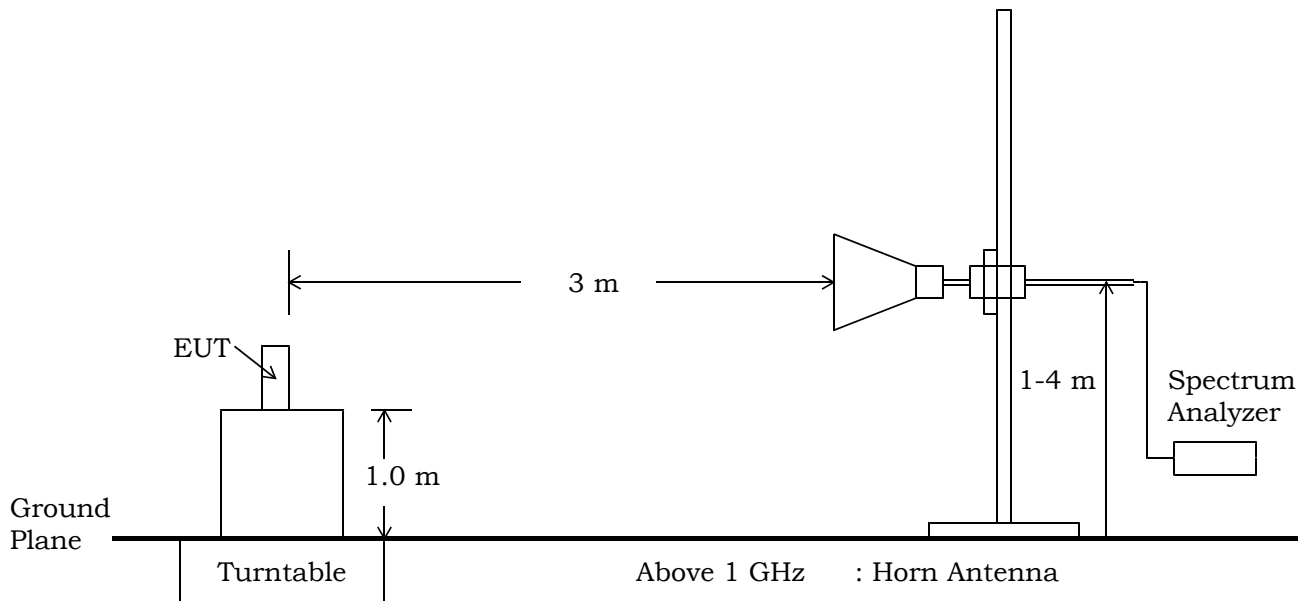


(a) Measurement set up for up to 30 MHz

Fig.4 Unwanted Radiation Measurement



(b) Measurement set up for up to 1 GHz



(c) Measurement set up for above 1GHz

Fig.4 Unwanted Radiation Measurement

Test location:

KITA-KANSAI Testing Center

7-7, Ishimaru, 1-Chome, Mino-Shi, Osaka, 562-0027, Japan

● - 1st open test site (3 meters)

KAMEOKA EMC Branch

9-1, Ozaki, Inukanno, Nishibetsuin-Cho, Kameoka-Shi, Kyoto, 621-0126, Japan

○ - 1st open test site ○ - 3 m ○ - 10 m ○ - 30 m

○ - 2nd open test site ○ - 3 m ○ - 10 m

Validation of Site Attenuation:

1) Last Confirmed Date : October 3, 2005

2) Interval : 1 Year

Used test instruments :

Model No.	Device ID	Last Cal. Date	Cal. Interval
● - ESCS 30	A - 1	August, 2005	1 Year
○ - ESCS 30	A - 9		
○ - ESH 2	A - 2		
○ - ESH 2	A - 3		
● - HFH2-Z2	C - 2	August, 2005	1 Year
○ - HFH2-Z2	C - 3		
● - Cable	H - 28	August, 2005	1 Year
● - ESV/ESV-Z3	A - 6 / A - 20	June, 2006	1 Year
○ - ESVS 10	A - 5		
● - VHA9103/BBA9106	C - 43	August, 2005	1 Year
● - UHALP9107	C - 42	August, 2005	1 Year
● - VHA9103/FBAB9177	C - 27	August, 2005	1 Year
● - UHALP9108-A1	C - 26	August, 2005	1 Year
○ - KBA-511	C - 12		
○ - KBA-611	C - 22		
● - Cable	H - 5	August, 2005	1 Year

- continue -

Used test instruments :

Model No.	Device ID	Last Cal. Date	Cal. Interval
○ - 8566B	A - 13		
○ - E4417A	B - 51		
○ - E9321A	B - 52		
● - N1911A	B - 63	June, 2006	1 Year
● - N1921A	B - 64	June, 2006	1 Year
● - E8257D	B - 39	July, 2005	2 Years
○ - 6062A	B - 44		
● - E4446A	A - 39	November, 2005	1 Year
○ - 4T-10	D - 73		
○ - 4T-10	D - 74		
● - 54-10	D - 82	May, 2006	1 Year
● - 54-10	D - 83	May, 2006	1 Year
● - WJ-6611-513	A - 23	May, 2006	1 Year
● - WJ-6882-824	A - 21	May, 2006	1 Year
● - DBL-0618N515	A - 33	May, 2006	1 Year
● - ALN-22093545-1	A - 37	February, 2006	1 Year
● - 91888-2	C - 40 - 1	June, 2006	1 Year
● - 91889-2	C - 40 - 2	June, 2006	1 Year
● - 94613-1	C - 40 - 3	June, 2006	1 Year
● - 91891-2	C - 40 - 4	June, 2006	1 Year
● - 94614-1	C - 40 - 5	June, 2006	1 Year
● - 91888-2	C - 41 - 1	June, 2006	1 Year
● - 91889-2	C - 41 - 2	June, 2006	1 Year
● - 94613-1	C - 41 - 3	June, 2006	1 Year
● - 91891-2	C - 41 - 4	June, 2006	1 Year
● - 94614-1	C - 41 - 5	June, 2006	1 Year
● - 3160-09	C - 48	June, 2006	2 Years
● - 8673D	B - 2	April, 2006	1 Year
● - Cable	C - 40 - 11	May, 2006	1 Year
● - Cable	C - 40 - 14	May, 2006	1 Year
● - Cable	C - 53	February, 2006	1 Year
● - Cable	C - 54	February, 2006	1 Year

Environmental conditions :

Temperature: 24 °C Humidity: 68 %

Occupied Bandwidth Measurement (§2.1049, §24.238)

Test Procedure :

The measurement test-setup is shown in Fig.5.

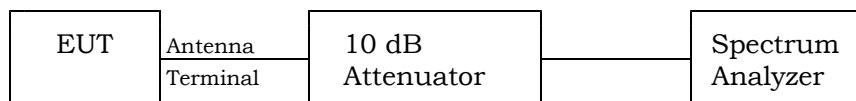


Fig.5 Occupied Bandwidth Measurement

The setting of the spectrum analyzer are shown as follows :

	PCS 1900
Res. Bandwidth	10 kHz
Video Bandwidth	30 kHz
Span	1 MHz
Sweep Time	>350msec
Trace	Maxhold

Test location :

KITA-KANSAI Testing Center

7-7, Ishimaru, 1-Chome, Mino-Shi, Osaka, 562-0027, Japan

● - Shielded room

KAMEOKA EMC Branch

9-1, Ozaki, Inukanno, Nishibetsuin-Cho, Kameoka-Shi, Kyoto, 621-0126, Japan

○ - Shielded room

Used test instruments:

Model No.	Device ID	Last Cal. Date	Cal. Interval
○ - 8566B	A - 13	November, 2005	1 Year
● - E4446A	A - 39		
○ - 4T-10	D - 73		
○ - 4T-10	D - 74		
○ - 2-10	D - 79		
○ - 2-10	D - 80	May, 2006	1 Year
○ - 54-10	D - 82		
● - 54-10	D - 83		

Environmental conditions:

Temperature: 26 °C Humidity: 61 %

Band-Edge Emission Measurement (§2.1049, §22.917, §24.238)

Test Procedure :

The measurement test-setup is shown in Fig.6.

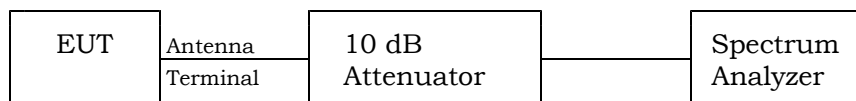


Fig.6 Band-Edge Emission Measurement

The setting of the spectrum analyzer are shown as follows :

	PCS 1900
TX Frequency	1850.20 MHz / 1909.8 MHz
Band-edge Frequency	1850.00 MHz / 1910.0 MHz
Res. Bandwidth	3 kHz
Video Bandwidth	10 kHz
Span	2 MHz
Sweep Time	AUTO
Trace	Maxhold

Test location :

KITA-KANSAI Testing Center

7-7, Ishimaru, 1-Chome, Mino-Shi, Osaka, 562-0027, Japan

● - Shielded room

KAMEOKA EMC Branch

9-1, Ozaki, Inukanno, Nishibetsuin-Cho, Kameoka-Shi, Kyoto, 621-0126, Japan

○ - Shielded room

Used test instruments:

Model No.	Device ID	Last Cal. Date	Cal. Interval
○ - 8566B	A - 13	November, 2005	1 Year
● - E4446A	A - 39		
○ - 4T-10	D - 73		
○ - 4T-10	D - 74		
○ - 2-10	D - 79		
○ - 2-10	D - 80	May, 2006	1 Year
○ - 54-10	D - 82		
● - 54-10	D - 83		

Environmental conditions:

Temperature: 26 °C Humidity: 61 %

Frequency Stability Measurement(§2.1055, §24.235)

Test Procedure :

a) Frequency Stability Measurement versus Temperature

The EUT was placed in an environmental chamber and was tested in the range from -30 to +50 degrees Celsius. The EUT was stabilized at each temperature. The power (4.0VDC) supplied was applied to the transmitter and allowed to stabilize for 10 minutes. The transmitting frequency was measured at startup and 2 minutes, 5 minutes and 10 minutes after startup. This procedure was repeated from -30 to +50 degrees Celsius at the interval of 10 degrees.

b) Frequency Stability Measurement versus Power Supply Voltage

The EUT was placed in an environmental chamber and was tested at the temperature of +20 degrees Celsius. The EUT was stabilized at the temperature. The power (4.0VDC) and the power (3.7VDC, the Ending Voltage) was applied to the EUT allowed to stabilize for 10 minutes. The transmitting frequency was measured at startup and 2 minutes, 5 minutes and 10 minutes after startup.

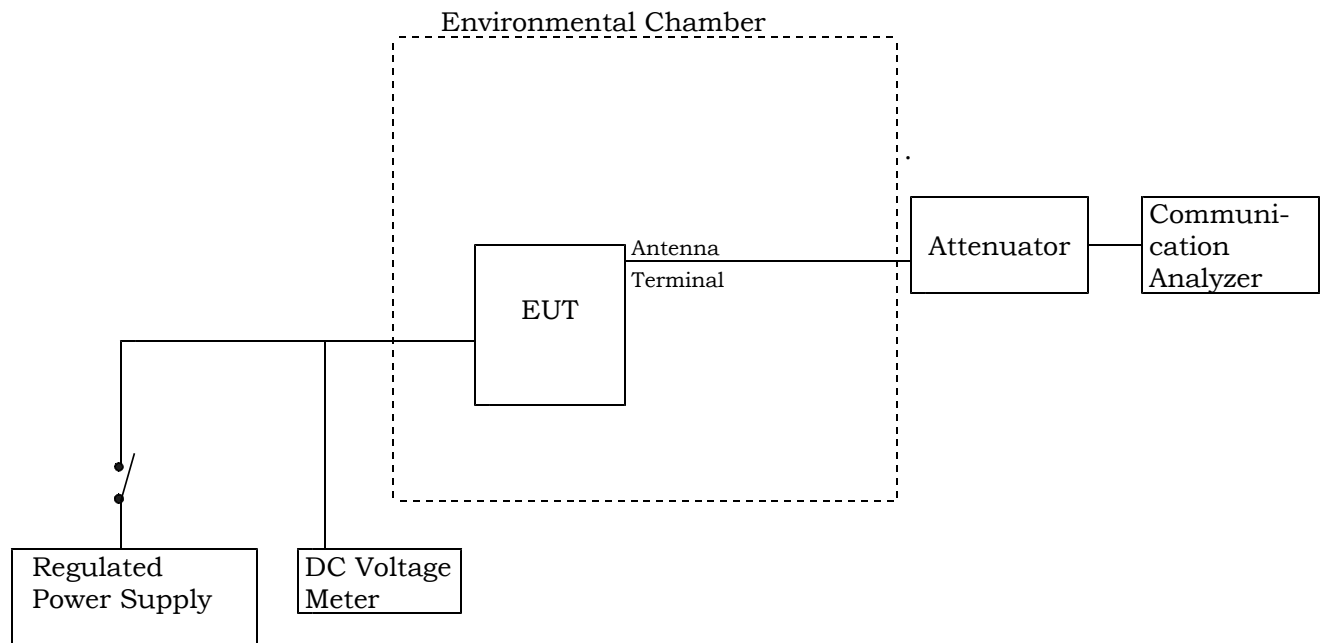


Fig.7 Frequency Stability Measurement

Test location:

KITA-KANSAI Testing Center

7-7, Ishimaru, 1-Chome, Mino-Shi, Osaka, 562-0027, Japan

○ - Shielded room

● - Environment Testing Room

KAMEOKA EMC Branch

9-1, Ozaki, Inukanno, Nishibetsuin-Cho, Kameoka-Shi, Kyoto, 621-0126, Japan

○ - Shielded room

Used test instruments and sites :

Model No.	Device ID	Last Cal. Date	Cal. Interval
● - PL-4K	G47001018-1	November, 2005	1 Year
● - SRF106AS00000M11	G47001018-3	November, 2005	1 Year
● - NL035-10	F - 4	April, 2006	1 Year
● - 6032A	F - 5	April, 2006	1 Year
● - CMU200	B - 21	April, 2006	1 Year
● - TR5212	B - 30	March, 2006	1 Year

CONFIGURATION OF EUT

The Equipment Under Test (EUT) consists of :

Description	Applicant (Manufacturer)	Model No. (Serial No.)	FCC ID
WCDMA & Tri-band GSM Dual mode Mobile Phone / Bluetooth Enable	Sharp Corporation (Sharp Corporation)	810SH (004401/11/020 464/7)	APYHRO00050
Lithium-ion Battery	Sharp Corporation (Sharp Corporation)	SHBAR1 (---)	N/A
AC CHARGER	Sharp Corporation (Sharp Corporation)	XN-1QC71 (---)	N/A
Stereo Headset	Sharp Corporation (Sharp Corporation)	XN-1HS90 (---)	N/A
Handsfree Microphone Unit	Sharp Corporation (Sharp Corporation)	XN-1HU90 (---)	N/A

The measurement was carried out with the following equipment connected :

Description	Grantee/Distributor	Model No. (Serial No.)	FCC ID
None			

Type of Interface Cable(s) and the AC Power Cord used with the EUT :

	Description	Port	Shielded Cable	Shell Material	Ferrite Core	Cable Length
1	Mobile Phone	USB	NO	--	NO	1.5 m
	DC Power Cord(AC Charger)	---		--		
2	Mobile Phone	EARPHONE	NO	--	NO	0.8 m
	Handsfree Microphone Unit	---		--		
3	Handsfree Microphone Unit	---	NO	--	NO	0.9 m
	Stereo Headset	---		--		

Test Configuration:**Operation - mode of the EUT:**

The tests were carried out under one modulation type shown as follows :
Modulation Burst Signal : DATA TSC 5 in accordance with GSM 05.02.

The Radiated Emission tests were carried under 3 test configurations in page 26 shown as follows:

	Test Configuration	The condition of the transmitting antenna
1	Single Unit	Integrated antenna
2	AC Charger used	Integrated antenna
3	Stereo Headset used	Integrated antenna

In all test, the fully charged battery is used for the EUT.

Test system:

The Mobile Phone has 2 ports shown as follows :

- 1) EARPHONE port : is connected to the Stereo Headset.
- 2) USB port : is connected to the AC Charger or the personal computer.

Special accessories:

None

Detailed Transmitter portion:

PCS1900

Transmitting frequency : 1850.2 MHz(512ch) - 1909.8 MHz(810ch)

Local frequency : 1850.2 MHz(512ch) - 1909.8 MHz(810ch)

Detailed Receiver portion:

PCS1900

Receiving frequency : 1930.2 MHz(512ch) - 1989.8 MHz(810ch)

Local frequency : 3860.4 MHz(512ch) - 3979.6 MHz(810ch)

Other Clock Frequency:

RTC : 32.768 kHz

Reference frequency : 13.0 MHz

EUT Modification

- - No modifications were conducted by JQA to achieve compliance to applied levels.
- - To achieve compliance to applied levels, the following change(s) were made by JQA during the compliance test.

— The modification(s) will be implemented in all production models of this equipment. —

Applicant : N/A Date : N/A

Typed Name : N/A Position : N/A

Responsible Party

— Responsible Party of Test Item(Product) —

Responsible party :

Contact Person :

Signatory

Deviation from Standard

- - No deviations from the standard described in page 3.
- - The following deviations were employed from the standard described in page 3.

TEST RESULTS
PCS1900**Transmitter Power(TP)**The transmitter power is 704.7 mW at 1850.20 MHzUncertainty of measurement results at Amplitude ±0.19 dB(2σ)**Remarks:** _____
_____**Antenna Conducted Spurious Emission**The requirements are **● - Passed** **○ - Not Passed**Min. limit margin 31.1 dB at 3700.400 MHz

Max. limit exceeding _____ dB at _____ MHz

Uncertainty of measurement results at Amplitude ±0.24 dB(2σ)**Remarks:** _____
_____**Transmitter Power(EIRP)**The requirements are **● - Passed** **○ - Not Passed**The Maximum EIRP is 1.585 W at 1880.00 MHzMin. limit margin 1.0 dB at 1880.00 MHz

Max. limit exceeding _____ dB at _____ MHz

Uncertainty of measurement results +1.3 dB(2σ) -1.3 dB(2σ)**Remarks:** The measurement result is within the range of measurement uncertainty.

Unwanted Radiation (9 kHz - 20 GHz)

The requirements are		● - Passed	○ - Not Passed
Min. limit margin	More than	<u>9.5</u> dB	at <u>19098.00</u> MHz
Max. limit exceeding		<u> </u> dB	at <u> </u> MHz
Uncertainty of measurement results	9 kHz - 30 MHz	<u>+2.5</u> dB(2σ)	<u>-2.5</u> dB(2σ)
	30 MHz - 1 GHz	<u>+4.1</u> dB(2σ)	<u>-4.2</u> dB(2σ)
	1 GHz - 20 GHz	<u>+3.1</u> dB(2σ)	<u>-3.2</u> dB(2σ)

Remarks: _____

Occupied Bandwidth

The requirements are		● - Passed	○ - Not Passed
The 26dB Bandwidth is		<u>322.7</u> kHz	at <u>1850.20</u> MHz
The 99% Bandwidth is		<u>246.0</u> kHz	at <u>1909.80</u> MHz
The results(Occupied Bandwidth)		Refer to pages* 2 - 4	
Uncertainty of measurement results	at Frequency	<u>±1.7</u> kHz(2σ)	
Uncertainty of measurement results	at Amplitude	<u>±0.24</u> dB(2σ)	

Remarks: *: The Page is one in the Attachment A.

Band-Edge Emission

The requirements are		● - Passed	○ - Not Passed
The Band-Edge level is		<u>-39.0</u> dBc	at <u>1910.00</u> MHz
The results(Band-edge Emission)		Refer to pages* 6 - 7	
Uncertainty of measurement results	at Frequency	<u>±6.9</u> kHz(2σ)	
Uncertainty of measurement results	at Amplitude	<u>±0.24</u> dB(2σ)	

Remarks: *: The Page is one in the Attachment A.



JQA Application No. : KL80060199
Model No. : 810SH
FCC ID : APYHRO00050

Regulation : CFR 47 FCC Rules Part 24
Issue Date : August 15, 2006

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Frequency Stability

Frequency Stability : +0.04 ppm at 1880.000 MHz

Uncertainty of measurement results ±10 Hz

Remarks:

SUMMARY

GENERAL REMARKS :

The EUT was tested according to the requirements of FCC Rules and Regulations Part 24 (October 1, 2004) under the test configuration, as shown in page 26.

The conclusion for the test items of which are required by the applied regulation is indicated under the final judgement.

Test Results :

The "as received" sample;

- - fulfill the test requirements of the regulation mentioned on page 3.
- - fulfill the test requirements of the regulation mentioned on page 3, but with certain qualifications.
- - doesn't fulfill the test regulation mentioned on page 3.

Begin of testing : July 31, 2006

End of testing : August 9, 2006

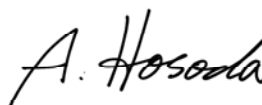
- JAPAN QUALITY ASSURANCE ORGANIZATION -

Reviewed by :

Tested by :



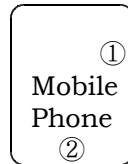
Shigeru Kinoshita
Deputy Manager
EMC Div.
JQA KITA-KANSAI Testing Center



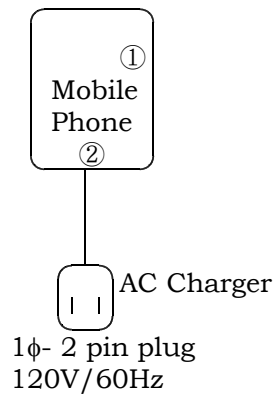
Akio Hosoda
Manager
EMC Div.
JQA KITA-KANSAI Testing Center

Test System-Arrangement (Drawings)

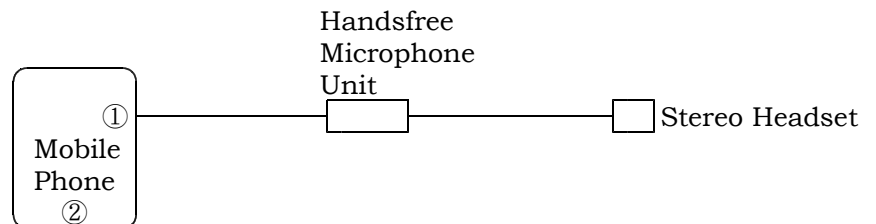
1) Single Unit



2) AC Charger used



3) Stereo Headset used



Note:

- ① : EARPHONE
② : Charger/USB

Test-Setup (Photographs) at worst case

This page is CONFIDENTIAL.
Refer to PDF(TestSetup_Photo_Part24)



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Test-Setup (Photographs) at three orthogonal axis

This page is CONFIDENTIAL.
Refer to PDF(TestSetup_Photo_Part24)

**Transmitter Power(TP) Measurement
(PCS 1900MHz Band)**Test Date: August 9, 2006Temp.: 26 °C, Humi: 61 %

Transmitting Frequency CH	[MHz]	Correction Factor [dB]	Meter Reading (Peak) [dBm]	Results (Peak)	
				[dBm]	[mW]
512	1850.200	20.00	8.48	28.48	704.7
661	1880.000	20.00	8.37	28.37	687.1
810	1909.800	20.00	8.25	28.25	668.3

Calculated result at 1850.200 MHz, as the maximum level point shown on underline:

Correction Factor	=	20.00	dBm
+) Meter Reading	=	8.48	dB
Result	=	28.48	dBm = 704.7 mW

NOTE : The correction factor shows the attenuation pad loss including the short, low loss cable or adapter.

Tester: Shigeru Kinoshita

Antenna-Conducted Spurious Emission Measurement (PCS 1900MHz Band)

Test Date: August 9, 2006
Temp.: 26 °C, Humi: 61 %

CH	Transmitting Frequency [MHz]	Measured Frequency [MHz]	Corr. Factor [dB]	Meter Readings [dBm]	Limits [dBm]	Results [dBm]	Margin [dB]	Remarks
512	1850.200	3700.400	11.3	-55.4	-13.0	-44.1	+31.1	C
		5550.600	11.3	-57.6	-13.0	-46.3	+33.3	C
		7400.800	11.1	< -60.0	-13.0	< -48.9	> +35.9	C
		9251.000	11.1	< -60.0	-13.0	< -48.9	> +35.9	C
		11101.200	11.4	< -60.0	-13.0	< -48.6	> +35.6	C
		12951.400	11.6	< -60.0	-13.0	< -48.4	> +35.4	C
		14801.600	11.8	< -60.0	-13.0	< -48.2	> +35.2	C
		16651.800	11.9	< -60.0	-13.0	< -48.1	> +35.1	C
		18502.000	12.1	< -60.0	-13.0	< -47.9	> +34.9	C
661	1880.000	3760.000	11.3	-56.7	-13.0	-45.4	+32.4	C
		5640.000	11.3	< -60.0	-13.0	< -48.7	> +35.7	C
		7520.000	11.1	< -60.0	-13.0	< -48.9	> +35.9	C
		9400.000	11.1	< -60.0	-13.0	< -48.9	> +35.9	C
		11280.000	11.4	< -60.0	-13.0	< -48.6	> +35.6	C
		13160.000	11.6	< -60.0	-13.0	< -48.4	> +35.4	C
		15040.000	11.8	< -60.0	-13.0	< -48.2	> +35.2	C
		16920.000	11.9	< -60.0	-13.0	< -48.1	> +35.1	C
		18800.000	12.1	< -60.0	-13.0	< -47.9	> +34.9	C
810	1909.800	3819.600	11.3	< -60.0	-13.0	< -48.7	> +35.7	C
		5729.400	11.2	< -60.0	-13.0	< -48.8	> +35.8	C
		7639.200	11.1	< -60.0	-13.0	< -48.9	> +35.9	C
		9549.000	11.2	< -60.0	-13.0	< -48.8	> +35.8	C
		11458.800	11.4	< -60.0	-13.0	< -48.6	> +35.6	C
		13368.600	11.6	< -60.0	-13.0	< -48.4	> +35.4	C
		15278.400	11.8	< -60.0	-13.0	< -48.2	> +35.2	C
		17188.200	12.0	< -60.0	-13.0	< -48.0	> +35.0	C
		19098.000	12.1	< -60.0	-13.0	< -47.9	> +34.9	C

Calculated result at 3700.4 MHz, as the worst point shown on underline:

Corr. Factor	=	11.3 dB
+) Meter Reading	=	-55.4 dBm
Result	=	-44.1 dBm

Minimum Margin: $-13.0 - (-44.1) = 31.1$ (dB)

NOTES

- The spectrum was checked from 9 kHz to 20 GHz.
- The spectrum analyzer displays were printed out in attachment B.
- Applied limits : -13.0 [dBm] = $10\log(\text{TP}[\text{mW}]) - (43 + 10\log(\text{tp}[\text{W}])) = 10\log(\text{TP}[\text{mW}]) - (43 + (10 \log(\text{TP}[\text{mW}]) - 30))$
 where, $\text{tp}[\text{W}] = \text{TP}[\text{mW}] / 1000$: Transmitter power at antenna terminal
- The correction factor is shown as follows:
 Corr. Factor [dB] = Cable Loss + 10dB Pad Att. [dB] (9 kHz - 2.2 GHz)
 Corr. Factor [dB] = Cable Loss + 20dB Pad Att. + High Pass Filter Loss (D-42) - Pre-Amp. Gain [dB] (over 2.2 GHz)
- The symbol of "<" means "or less".
- The symbol of ">" means "more than".
- Setting of measuring instrument(s) :

	Detector Function	RES B.W.	V.B.W.	Sweep Time
A	Peak	10 kHz	30 kHz	20 msec.
B	Peak	100 kHz	300 kHz	20 msec.
C	Peak	1 MHz	3 MHz	20 msec.

Tester : Shigeru Kinoshita

Transmitter Power(EIRP) Measurement (PCS 1900MHz Band)

Test Date: July 31, 2006
 Temp.: 24 °C, Humi: 68 %

1. Measurement Results

CH	Transmitting Frequency [MHz]	Emission Measurement [dB(μV)]		Substitution Measurement [dB(μV)]		Supplied Power to Substitution Antenna [dBm]	Gain of Substitution Antenna [dB]
		Hori. (Mh)	Vert. (Mv)	Hori. (Msh)	Vert. (Msv)		
512	1850.200	94.5	94.8	76.5	76.4	- 0.8	14.3
661	1880.000	94.9	95.2	76.6	76.7	- 0.8	14.3
810	1909.800	94.7	94.7	76.9	77.0	- 0.8	14.4

2. Calculation Results

CH	Transmitting Frequency [MHz]	Peak EIRP [dBm]		Maximum Peak EIRP [W]	Limits [dBm]	Margin [dB]
		(EIRPh)	Vert. (EIRPv)			
512	1850.200	31.5	31.9	1.549	33.0	+ 1.1
661	1880.000	31.8	32.0	1.585	33.0	+ 1.0
810	1909.800	31.4	31.3	1.380	33.0	+ 1.6

Calculated result at 1880.000 MHz, as the worst point shown on underline:

Emission Measurement (Mv)	=	95.2 dB(mV)
Substitution Measurement (Msv)	=	-76.7 dB(mV)
Supplied Power to Substitution Antenna	=	-0.8 dBm
+) Gain of Substitution Antenna	=	14.3 dB
Result (ERPv)	=	32.0 dBm = 1.585 W

Minimum Margin: 33.0 - 32.0 = 1.0 (dB)

NOTE : Setting of measuring instrument(s) :

Detector Function	Resolution B.W.	V.B.W.	Sweep Time
Peak	1 MHz	1 MHz	20 msec.

Tester: _____ Akio Hosoda

Unwated Radiation Measurement (PCS 1900MHz Band)

Test Configuration : Single Unit

Test Date: August 1, 2006
 Temp.: 24 °C, Humi: 68 %

CH	Transmitting Frequency [MHz]	Measured Frequency [MHz]	ERP [dBm]		Limits [dBm]	Margin [dB]	Remarks
			Hori.	Vert.			
512	1850.200	3700.400	< -32.9	< -32.9	-13.0	> +19.9	C
		5550.600	< -30.7	< -30.7	-13.0	> +17.7	C
		7400.800	< -29.3	< -29.3	-13.0	> +16.3	C
		9251.000	< -33.6	< -33.6	-13.0	> +20.6	C
		11101.200	< -33.3	< -33.3	-13.0	> +20.3	C
		12951.400	< -27.8	< -27.8	-13.0	> +14.8	C
		14801.600	< -27.7	< -27.7	-13.0	> +14.7	C
		16651.800	< -28.9	< -28.9	-13.0	> +15.9	C
		18502.000	< -23.5	< -23.5	-13.0	> +10.5	C
661	1880.000	3760.000	< -33.2	< -33.2	-13.0	> +20.2	C
		5640.000	< -30.3	< -30.3	-13.0	> +17.3	C
		7520.000	< -28.5	< -28.5	-13.0	> +15.5	C
		9400.000	< -33.9	< -33.9	-13.0	> +20.9	C
		11280.000	< -33.1	< -33.1	-13.0	> +20.1	C
		13160.000	< -27.6	< -27.6	-13.0	> +14.6	C
		15040.000	< -28.1	< -28.1	-13.0	> +15.1	C
		16920.000	< -29.1	< -29.1	-13.0	> +16.1	C
		18800.000	< -23.0	< -23.0	-13.0	> +10.0	C
810	1909.800	3819.600	< -33.3	< -33.3	-13.0	> +20.3	C
		5729.400	< -30.3	< -30.3	-13.0	> +17.3	C
		7639.200	< -33.7	< -33.7	-13.0	> +20.7	C
		9549.000	-34.0	< -34.1	-13.0	+21.0	C
		11458.800	< -33.2	< -33.2	-13.0	> +20.2	C
		13368.600	< -27.4	< -27.4	-13.0	> +14.4	C
		15278.400	< -28.4	< -28.4	-13.0	> +15.4	C
		17188.200	< -28.9	< -28.9	-13.0	> +15.9	C
		19098.000	< -22.5	< -22.5	-13.0	> + 9.5	C

Calculated result at 19098.0 MHz, as the worst point shown on underline:
 Minimum Margin: $-13.0 - (<-22.5) = >9.5$ (dB)

NOTES

1. Test Distance : 3 m
2. The spectrum was checked from 9 kHz to 20 GHz.
3. All emissions not reported were more than 20 dB below the applied limits.
4. Applied limits : -13.0 [dBm] = $10\log(TP[mW]) - (43 + 10\log(tp[W])) = 10\log(TP[mW]) - (43 + (10 \log(TP[mW]) - 30))$
 where, $tp[W] = TP[mW] / 1000$: Transmitter power at antenna terminal
5. The symbol of "<" means "or less".
6. The symbol of ">" means "more than".
7. Setting of measuring instrument(s) :

	Detector Function	RES B.W.	V.B.W.	Sweep Time
A	Peak	10 kHz	30 kHz	20 msec.
B	Peak	100 kHz	300 kHz	20 msec.
C	Peak	1 MHz	3 MHz	20 msec.

Tester: Akio Hosoda

Occupied Bandwidth Measurement (PCS 1900MHz Band)

Test Date: August 9, 2006
Temp.: 26 °C ; Humi.: 61 %

CH No.	Transmitting Frequency(MHz)	26dB Bandwidth	99% Bandwidth	Data Page*
512	1850.200	322.7 kHz	245.7 kHz	Page 2
661	1880.000	319.5 kHz	244.6 kHz	Page 3
810	1909.800	317.9 kHz	246.0 kHz	Page 4

Note) 1. *: The Data Page is one in Attachment A.
2. The point shown on " _____ " is the Maximum Margin Point.

Tester : Shigeru Kinoshita

Band-Edge Emission Measurement
(PCS 1900MHz Band)Test Date: August 9, 2006
Temp.: 26 °C ; Humi.: 61 %

1) Low Band-Edge Measurement

CH	Transmitting Frequency(MHz)	Band-Edge Frequency(MHz)	Band-Edge Level[dBc]	Data Page*
512	1850.200	1850.000	-42.1	Page 6

2) High Band-Edge Measurement

CH	Transmitting Frequency(MHz)	Band-Edge Frequency(MHz)	Band-Edge Level[dBc]	Data Page*
810	1909.800	1910.000	-39.0	Page 7

Note) 1. *: The Data Page is one in Attachment A.
2. The point shown on "_____" is the Minimum Point.

Tester : Shigeru Kinoshita

Frequency Stability Measurement (PCS 1900MHz Band)

Test Date: August 5, 2006

1. Frequency Stability Measurement versus Temperature

Transmitting Frequency : 1880.000 MHz (661 ch)
 DC Supply Voltage : 4.0 VDC

Ambient Temperature [°C]	Startup	Deviation [ppm]			Limits [ppm]	Margin [ppm]
		2 minutes	5 minutes	10 minutes		
-30	<u>+ 0.04</u>	+ 0.03	<u>- 0.04</u>	+ 0.02	N/A	N/A
-20	<u>+ 0.04</u>	<u>+ 0.04</u>	- 0.03	+ 0.02	N/A	N/A
-10	+ 0.03	<u>+ 0.04</u>	+ 0.03	- 0.02	N/A	N/A
0	- 0.03	+ 0.02	+ 0.01	- 0.02	N/A	N/A
10	<u>- 0.04</u>	- 0.03	+ 0.02	+ 0.02	N/A	N/A
20	- 0.03	<u>- 0.04</u>	- 0.03	- 0.02	N/A	N/A
30	<u>- 0.04</u>	- 0.02	- 0.03	+ 0.03	N/A	N/A
40	- 0.03	- 0.02	+ 0.01	- 0.01	N/A	N/A
50	+ 0.03	- 0.02	+ 0.01	+ 0.02	N/A	N/A

2. Frequency Stability Measurement versus Power Supply Voltage

Transmitting Frequency : 1880.000 MHz (661 ch)
 DC Supply Voltage : 20 °C

Ambient Temperature [°C]	Startup	Deviation [ppm]			Limits [ppm]	Margin [ppm]
		2 minutes	5 minutes	10 minutes		
4.0	- 0.03	<u>- 0.04</u>	- 0.03	- 0.02	N/A	N/A
3.7(Ending)	<u>- 0.04</u>	<u>- 0.04</u>	- 0.03	- 0.02	N/A	N/A

Test condition example as the maximum deviation point shown on underline:

Ambient Temperature : -30 °C / Startup
 DC Supply Voltage : 4 VDC

NOTE : The measurement were made after all of components of the oscillator sufficiently stabilized at each temperature.

Tester: Yuichi Fukumoto